Documents

## TMUX1109 5 V, $\pm 2.5$ V, Low-Leakage-Current, 4:1, 2-Channel Precision Multiplexer

## 1 Features

- Single Supply Range: 1.08 V to 5.5 V
- Dual Supply Range: $\pm 2.75 \mathrm{~V}$
- Low Leakage Current: 3 pA
- Low Charge Injection: 1 pC
- Low On-Resistance: $1.8 \Omega$
- $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ Operating Temperature
- 1.8 V Logic Compatible
- Fail-Safe Logic
- Rail to Rail Operation
- Bidirectional Signal Path
- Break-Before-Make Switching
- ESD Protection HBM: 2000 V


## 2 Applications

- Ultrasound Scanners
- Patient Monitoring \& Diagnostics
- Optical Networking
- Optical Test Equipment
- Remote Radio Unit
- Wired Networking
- ATE Test Equipment
- Factory Automation and Industrial Controls
- Programmable Logic Controllers (PLC)
- Analog Input Modules
- SONAR Receivers
- Motor Drive
- Servo Drive Position Feedback



## 3 Description

The TMUX1109 is a precision complementary metaloxide semiconductor (CMOS) multiplexer (MUX). The TMUX1109 offers differential $4: 1$ or dual $4: 1$ singleended channels. Wide operating supply of 1.08 V to 5.5 V allows for use in a broad array of applications from medical equipment to industrial systems. The device supports bidirectional analog and digital signals on the source ( Sx ) and drain (D) pins ranging from GND to $\mathrm{V}_{\mathrm{DD}}$. All logic inputs have 1.8 V logic compatible thresholds, ensuring both TTL and CMOS logic compatibility when operating in the valid supply voltage range. Fail-Safe Logic circuitry allows voltages on the control pins to be applied before the supply pin, protecting the device from potential damage.

The TMUX1109 is part of the precision switches and multiplexers family of devices. These devices have very low on and off leakage currents and low charge injection, allowing them to be used in high precision measurement applications. A low supply current of 8 nA and small package options enable use in portable applications.

Device Information ${ }^{(1)}$

| PART NUMBER | PACKAGE | BODY SIZE (NOM) |
| :---: | :--- | :--- |
| TMUX1109 | TSSOP $(16)$ | $5.00 \mathrm{~mm} \times 4.40 \mathrm{~mm}$ |
|  | QFN $(16)$ | $2.60 \mathrm{~mm} \times 1.80 \mathrm{~mm}$ |

(1) For all available packages, see the package option addendum at the end of the data sheet.

Block Diagram


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## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| DATE | REVISION | NOTES |
| :---: | :---: | :---: |
| December 2018 | $*$ | Initial release. |

## 5 Pin Configuration and Functions



Pin Functions

| PIN |  |  | TYPE ${ }^{(1)}$ | DESCRIPTION |
| :---: | :---: | :---: | :---: | :---: |
| NAME | TSSOP | UQFN |  |  |
| A0 | 1 | 15 | 1 | Address line 0. Controls the switch configuration as shown in Table 1. |
| EN | 2 | 16 | 1 | Active high logic input. When this pin is low, all switches are turned off. When this pin is high, the $\mathrm{A}[1: 0]$ address inputs determine which switch is turned on. |
| VSS | 3 | 1 | P | Negative power supply. This pin is the most negative power-supply potential. For reliable operation, connect a decoupling capacitor ranging from $0.1 \mu \mathrm{~F}$ to $10 \mu \mathrm{~F}$ between $\mathrm{V}_{\mathrm{SS}}$ and GND. $\mathrm{V}_{\mathrm{SS}}$ can be connected to ground for single supply applications. |
| S1A | 4 | 2 | I/O | Source pin 1A. Can be an input or output. |
| S2A | 5 | 3 | I/O | Source pin 2A. Can be an input or output. |
| S3A | 6 | 4 | I/O | Source pin 3A. Can be an input or output. |
| S4A | 7 | 5 | I/O | Source pin 4A. Can be an input or output. |
| DA | 8 | 6 | I/O | Drain pin A. Can be an input or output. |
| DB | 9 | 7 | I/O | Drain pin B. Can be an input or output. |
| S4B | 10 | 8 | I/O | Source pin 4B. Can be an input or output. |
| S3B | 11 | 9 | I/O | Source pin 3B. Can be an input or output. |
| S2B | 12 | 10 | I/O | Source pin 2B. Can be an input or output. |
| S1B | 13 | 11 | I/O | Source pin 1B. Can be an input or output. |
| VDD | 14 | 12 | P | Positive power supply. This pin is the most positive power-supply potential. For reliable operation, connect a decoupling capacitor ranging from $0.1 \mu \mathrm{~F}$ to $10 \mu \mathrm{~F}$ between $\mathrm{V}_{\mathrm{DD}}$ and GND. |
| GND | 15 | 13 | P | Ground (0 V) reference |
| A1 | 16 | 14 | 1 | Address line 1. Controls the switch configuration as shown in Table 1. |

(1) $\mathrm{I}=$ input, $\mathrm{O}=$ output, $\mathrm{I} / \mathrm{O}=$ input and output, $\mathrm{P}=$ power

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) ${ }^{(1)}{ }^{(2)}{ }^{(3)}$

|  |  | MIN | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{DD}}-\mathrm{V}_{\text {SS }}$ |  | -0.5 | 6 | V |
| $\mathrm{V}_{\mathrm{DD}}$ | Supply voltage | -0.5 | 6 | V |
| $V_{S S}$ |  | -3.0 | 0.3 | V |
| $\mathrm{V}_{\text {SEL }}$ or $\mathrm{V}_{\text {EN }}$ | Logic control input pin voltage (EN, A0, A1) | -0.5 | 6 | V |
| $\mathrm{I}_{\text {SEL }}$ or $\mathrm{I}_{\text {EN }}$ | Logic control input pin current (EN, A0, A1) | -30 | 30 | mA |
| $\mathrm{V}_{S}$ or $\mathrm{V}_{\mathrm{D}}$ | Source or drain voltage (Sx, Dx) | -0.5 | $\mathrm{V}_{\mathrm{DD}}+0.5$ | V |
| $\mathrm{I}_{\text {S }}$ or $\mathrm{I}_{\mathrm{D}}$ (CONT) | Source or drain continuous current (Sx, Dx) | -30 | 30 | mA |
| $\mathrm{T}_{\text {stg }}$ | Storage temperature | -65 | 150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{J}$ | Junction temperature |  | 150 | ${ }^{\circ} \mathrm{C}$ |

(1) Stresses beyond those listed under Absolute Maximum Rating may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Condition. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum.
(3) All voltages are with respect to ground, unless otherwise specified.

### 6.2 ESD Ratings

| $\mathrm{V}_{(\mathrm{ESD})}$ |  | Electrostatic discharge | Human body model (HBM), per <br> ANSI/ESDA/JEDEC JS-001, all pins ${ }^{(1)}$ | VALUE |
| :--- | :--- | :--- | :---: | :---: | UNIT | U2000 |
| :---: |

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|  |  | MIN | NOM MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: |
| $V_{D D}$ | Positive power supply voltage (single) | 1.08 | 5.5 | V |
| $V_{S S}$ | Negative power supply voltage (dual) | -2.75 | 0 | V |
| $V_{D D}-V_{S S}$ | Supply rail voltage difference | 1.08 | 5.5 | V |
| $V_{S}$ or $V_{D}$ | Signal path input/output voltage (source or drain pin) (Sx, Dx) | $\mathrm{V}_{\mathrm{SS}}$ | $\mathrm{V}_{\mathrm{DD}}$ | V |
| $\begin{aligned} & \mathrm{V}_{\text {SEL }} \text { or } \\ & \mathrm{V}_{\text {EN }} \\ & \hline \end{aligned}$ | Logic control input pin voltage | 0 | 5.5 | V |
| $\mathrm{T}_{\text {A }}$ | Ambient temperature | -40 | 125 | ${ }^{\circ} \mathrm{C}$ |

### 6.4 Thermal Information

| THERMAL METRIC ${ }^{(1)}$ |  | TMUX1109 |  | UNIT |
| :---: | :---: | :---: | :---: | :---: |
|  |  | $\begin{gathered} \hline \text { PW (TSSOP) } \\ \hline 16 \text { PINS } \end{gathered}$ | $\begin{gathered} \hline \text { RSV (QFN) } \\ \hline 16 \text { PINS } \end{gathered}$ |  |
|  |  |  |  |  |
| $\mathrm{R}_{\text {өJA }}$ | Junction-to-ambient thermal resistance | 118.9 | 134.6 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\text {өJC(top) }}$ | Junction-to-case (top) thermal resistance | 49.3 | 74.3 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\text {өJB }}$ | Junction-to-board thermal resistance | 65.2 | 62.8 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\Psi_{J T}$ | Junction-to-top characterization parameter | 7.6 | 4.3 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\Psi_{J B}$ | Junction-to-board characterization parameter | 64.6 | 61.1 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\text {өJC }}$ (bot) | Junction-to-case (bottom) thermal resistance | N/A | N/A | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

[^0]TMUX1109
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### 6.5 Electrical Characteristics ( $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V} \pm 10$ \%)

at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}$ (unless otherwise noted)

|  | PARAMETER | TEST CONDITIONS | TA | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG SWITCH |  |  |  |  |  |  |  |
| RoN | On-resistance | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=0 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{DD}} \\ & \mathrm{I}_{\mathrm{SD}}=10 \mathrm{~mA} \end{aligned}$ <br> Refer to On-Resistance | $25^{\circ} \mathrm{C}$ |  | 1.8 | 4 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 4.5 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 4.9 | $\Omega$ |
| $\Delta \mathrm{R}_{\text {ON }}$ | On-resistance matching between channels | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=0 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{DD}} \\ & \mathrm{I}_{\mathrm{SD}}=10 \mathrm{~mA} \\ & \text { Refer to On-Resistance } \end{aligned}$ | $25^{\circ} \mathrm{C}$ |  | 0.18 |  | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 0.4 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 0.5 | $\Omega$ |
| $\begin{aligned} & \mathrm{R}_{\mathrm{ON}} \\ & \mathrm{FLAT} \end{aligned}$ | On-resistance flatness | $\begin{aligned} & V_{S}=0 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{DD}} \\ & \mathrm{I}_{\mathrm{SD}}=10 \mathrm{~mA} \end{aligned}$ <br> Refer to On-Resistance | $25^{\circ} \mathrm{C}$ |  | 0.85 |  | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 1.6 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 1.6 | $\Omega$ |
| $\mathrm{I}_{\text {S(OFF })}$ | Source off leakage current ${ }^{(1)}$ | $V_{D D}=5 \mathrm{~V}$ <br> Switch Off $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=4.5 \mathrm{~V} / 1.5 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{S}}=1.5 \mathrm{~V} / 4.5 \mathrm{~V} \end{aligned}$ <br> Refer to Off-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.08 | $\pm 0.005$ | 0.08 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.3 |  | 0.3 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -0.9 |  | 0.9 | nA |
| $\mathrm{I}_{\mathrm{D} \text { (OFF) }}$ | Drain off leakage current ${ }^{(1)}$ | $V_{D D}=5 \mathrm{~V}$ <br> Switch Off $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=4.5 \mathrm{~V} / 1.5 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{S}}=1.5 \mathrm{~V} / 4.5 \mathrm{~V} \end{aligned}$ <br> Refer to Off-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.1 | $\pm 0.01$ | 0.1 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.75 |  | 0.75 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -3.5 |  | 3.5 | nA |
| $\mathrm{I}_{\mathrm{D}(\mathrm{ON})}$ $\mathrm{I}_{\mathrm{S}(\mathrm{ON})}$ | Channel on leakage current | $V_{D D}=5 \mathrm{~V}$ <br> Switch On $\mathrm{V}_{\mathrm{D}}=\mathrm{V}_{\mathrm{S}}=2.5 \mathrm{~V}$ <br> Refer to On-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.025 | $\pm 0.003$ | 0.025 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.3 |  | 0.3 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -0.75 |  | 0.75 | nA |
| $\mathrm{I}_{\mathrm{D}(\mathrm{ON})}$ $\mathrm{I}_{\mathrm{S}(\mathrm{ON})}$ | Channel on leakage current | $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}$ <br> Switch On $V_{D}=V_{S}=4.5 \mathrm{~V} / 1.5 \mathrm{~V}$ <br> Refer to On-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.1 | $\pm 0.01$ | 0.1 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.75 |  | 0.75 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -3 |  | 3 | nA |
| LOGIC INPUTS (EN, A0, A1) |  |  |  |  |  |  |  |
| $\mathrm{V}_{1 \mathrm{H}}$ | Input logic high |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 1.49 |  | 5.5 | V |
| $\mathrm{V}_{\text {IL }}$ | Input logic low |  |  | 0 |  | 0.87 | V |
| $\begin{array}{\|l} \hline \mathrm{I}_{\mathrm{H}} \\ \mathrm{I}_{\mathrm{LL}} \\ \hline \end{array}$ | Input leakage current |  | $25^{\circ} \mathrm{C}$ |  | $\pm 0.005$ |  | $\mu \mathrm{A}$ |
| $\begin{aligned} & \mathrm{I}_{\mathrm{H}} \\ & \mathrm{I}_{\mathrm{LL}} \end{aligned}$ | Input leakage current |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | $\pm 0.05$ | $\mu \mathrm{A}$ |
| $\mathrm{C}_{\text {IN }}$ | Logic input capacitance |  | $25^{\circ} \mathrm{C}$ |  | 1 |  | pF |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 2 | pF |
| POWER SUPPLY |  |  |  |  |  |  |  |
| $\mathrm{I}_{\mathrm{DD}}$ | $\mathrm{V}_{\mathrm{DD}}$ supply current | Logic inputs $=0 \mathrm{~V}$ or 5.5 V | $25^{\circ} \mathrm{C}$ |  | 0.008 |  | $\mu \mathrm{A}$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 1 | $\mu \mathrm{A}$ |

(1) When $\mathrm{V}_{\mathrm{S}}$ is $4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{D}}$ is 1.5 V , and vice versa.

## Electrical Characteristics ( $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V} \pm 10$ \%) (continued)

at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}$ (unless otherwise noted)


### 6.6 Electrical Characteristics ( $\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V} \pm 10 \%$ )

at $T_{A}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}$ (unless otherwise noted)

|  | PARAMETER | TEST CONDITIONS | TA | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG SWITCH |  |  |  |  |  |  |  |
| $\mathrm{R}_{\text {ON }}$ | On-resistance | $\begin{aligned} & V_{S}=0 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{DD}} \\ & \mathrm{I}_{\mathrm{SD}}=10 \mathrm{~mA} \end{aligned}$ <br> Refer to On-Resistance | $25^{\circ} \mathrm{C}$ |  | 4 | 8.75 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 9.5 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 9.75 | $\Omega$ |
| $\Delta \mathrm{R}_{\text {ON }}$ | On-resistance matching between channels | $\begin{aligned} & V_{S}=0 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{DD}} \\ & \mathrm{I}_{\mathrm{SD}}=10 \mathrm{~mA} \end{aligned}$ <br> Refer to On-Resistance | $25^{\circ} \mathrm{C}$ |  | 0.13 |  | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 0.4 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 0.5 | $\Omega$ |
| $\mathrm{R}_{\mathrm{ON}}$ fLAT | On-resistance flatness | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=0 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{DD}} \\ & \mathrm{I}_{\mathrm{SD}}=10 \mathrm{~mA} \\ & \text { Refer to On-Resistance } \end{aligned}$ | $25^{\circ} \mathrm{C}$ |  | 1.9 |  | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  | 2 |  | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  | 2.2 |  | $\Omega$ |
| $\mathrm{I}_{\text {(OFF) }}$ | Source off leakage current ${ }^{(1)}$ | $\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}$ <br> Switch Off $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=3 \mathrm{~V} / 1 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{S}}=1 \mathrm{~V} / 3 \mathrm{~V} \end{aligned}$ <br> Refer to Off-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.05 | $\pm 0.001$ | 0.05 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.1 |  | 0.1 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -0.5 |  | 0.5 | nA |
| $\mathrm{I}_{\mathrm{D} \text { (OFF) }}$ | Drain off leakage current ${ }^{(1)}$ | $\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}$ <br> Switch Off $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=3 \mathrm{~V} / 1 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{S}}=1 \mathrm{~V} / 3 \mathrm{~V} \end{aligned}$ <br> Refer to Off-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.1 | $\pm 0.005$ | 0.1 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.5 |  | 0.5 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -2 |  | 2 | nA |
| $\mathrm{I}_{\mathrm{D}(\mathrm{ON})}$ $\mathrm{I}_{\mathrm{S}(\mathrm{ON})}$ | Channel on leakage current | $\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}$ <br> Switch On $V_{D}=V_{S}=3 \mathrm{~V} / 1 \mathrm{~V}$ <br> Refer to On-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.1 | $\pm 0.005$ | 0.1 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.5 |  | 0.5 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -2 |  | 2 | nA |
| LOGIC INPUTS (EN, A0, A1) |  |  |  |  |  |  |  |
| $\mathrm{V}_{\mathrm{IH}}$ | Input logic high |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 1.35 |  | 5.5 | V |
| $\mathrm{V}_{\mathrm{IL}}$ | Input logic low |  |  | 0 |  | 0.8 | V |
| $\begin{array}{\|l} \hline \mathrm{I}_{\mathrm{H}} \\ \mathrm{I}_{\mathrm{L}} \\ \hline \end{array}$ | Input leakage current |  | $25^{\circ} \mathrm{C}$ |  | $\pm 0.005$ |  | $\mu \mathrm{A}$ |
| $\begin{array}{\|l\|l} \mathrm{I}_{\mathrm{H}} \\ \mathrm{I}_{\mathrm{LL}} \\ \hline \end{array}$ | Input leakage current |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | $\pm 0.05$ | $\mu \mathrm{A}$ |
| $\mathrm{C}_{\text {IN }}$ | Logic input capacitance |  | $25^{\circ} \mathrm{C}$ |  | 1 |  | pF |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 2 | pF |
| POWER SUPPLY |  |  |  |  |  |  |  |
| $\mathrm{I}_{\mathrm{D}}$ | $\mathrm{V}_{\mathrm{DD}}$ supply current | Logic inputs $=0 \mathrm{~V}$ or 5.5 V | $25^{\circ} \mathrm{C}$ |  | 0.006 |  | $\mu \mathrm{A}$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 1 | $\mu \mathrm{A}$ |

(1) When $V_{S}$ is $3 \mathrm{~V}, \mathrm{~V}_{\mathrm{D}}$ is 1 V , and vice versa.

## Electrical Characteristics ( $\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V} \pm 10 \%$ ) (continued)

at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}$ (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS | TA | MIN TYP MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| DYNAMIC CHARACTERISTICS |  |  |  |  |  |
| $t_{\text {tran }}$ | Transition time between channels | $\begin{aligned} & V_{S}=2 \mathrm{~V} \\ & R_{L}=200 \Omega, C_{L}=15 \mathrm{pF} \end{aligned}$Refer to Transition Time | $25^{\circ} \mathrm{C}$ | 15 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 23 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 23 | ns |
| topen (BBM) | Break before make time | $\begin{aligned} & V_{S}=2 \mathrm{~V} \\ & R_{L}=200 \Omega, C_{L}=15 \mathrm{pF} \end{aligned}$ <br> Refer to Break-Before-Make | $25^{\circ} \mathrm{C}$ | 9 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 1 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 1 | ns |
| ton(EN) | Enable turn-on time | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=2 \mathrm{~V} \\ & \mathrm{R}_{\mathrm{L}}=200 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF} \\ & \text { Refer to } \mathrm{t}_{\mathrm{ON}(\mathrm{EN})} \text { and } \mathrm{t}_{\mathrm{OFF}(\mathrm{EN})} \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 14 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 25 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 25 | ns |
| toff(EN) | Enable turn-off time | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=2 \mathrm{~V} \\ & \mathrm{R}_{\mathrm{L}}=200 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF} \\ & \text { Refer to ton(EN) and toff(EN) } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 7 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 12 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 12 | ns |
| $Q_{C}$ | Charge Injection | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=1 \mathrm{~V} \\ & \mathrm{R}_{\mathrm{S}}=0 \Omega, \mathrm{C}_{\mathrm{L}}=1 \mathrm{nF} \end{aligned}$ <br> Refer to Charge Injection | $25^{\circ} \mathrm{C}$ | -1 | pC |
| OISo | Off Isolation | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF} \\ & \mathrm{f}=1 \mathrm{MHz} \\ & \text { Refer to Off Isolation } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | -65 | dB |
|  |  | $\begin{aligned} & R_{\mathrm{L}}=50 \Omega, C_{L}=5 \mathrm{pF} \\ & \mathrm{f}=10 \mathrm{MHz} \\ & \text { Refer to Off Isolation } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | -45 | dB |
| $\mathrm{X}_{\text {taLk }}$ | Crosstalk | $\begin{aligned} & R_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF} \\ & \mathrm{f}=1 \mathrm{MHz} \\ & \text { Refer to Crosstalk } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | -90 | dB |
|  |  | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF} \\ & \mathrm{f}=10 \mathrm{MHz} \\ & \text { Refer to Crosstalk } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | -80 | dB |
| BW | Bandwidth | $\mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF}$ <br> Refer to Bandwidth | $25^{\circ} \mathrm{C}$ | 135 | MHz |
| C SOFF | Source off capacitance | $\mathrm{f}=1 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 7 | pF |
| C ${ }_{\text {dofF }}$ | Drain off capacitance | $\mathrm{f}=1 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 32 | pF |
| Cson CDON | On capacitance | $\mathrm{f}=1 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 38 | pF |

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### 6.7 Electrical Characteristics ( $\mathrm{V}_{\mathrm{DD}}=2.5 \mathrm{~V} \pm 10 \%$ ), ( $\mathrm{V}_{\mathrm{SS}}=-2.5 \mathrm{~V} \pm 10 \%$ )

at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{DD}}=+2.5 \mathrm{~V}, \mathrm{~V}_{S S}=-2.5 \mathrm{~V}$ (unless otherwise noted)

|  | PARAMETER | TEST CONDITIONS | TA | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG SWITCH |  |  |  |  |  |  |  |
| Ron | On-resistance | $\begin{aligned} & V_{S}=V_{S S} \text { to } V_{D D} \\ & I_{S D}=10 \mathrm{~mA} \\ & \text { Refer to On-Resistance } \end{aligned}$ | $25^{\circ} \mathrm{C}$ |  | 1.8 | 4 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 4.5 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 4.9 | $\Omega$ |
| $\Delta \mathrm{R}_{\mathrm{ON}}$ | On-resistance matching between channels | $\begin{aligned} & V_{S}=V_{S S} \text { to } V_{D D} \\ & I_{S D}=10 \mathrm{~mA} \end{aligned}$ <br> Refer to On-Resistance | $25^{\circ} \mathrm{C}$ |  | 0.18 |  | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 0.4 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 0.5 | $\Omega$ |
| Ron | On-resistance flatness | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=\mathrm{V}_{\mathrm{SS}} \text { to } \mathrm{V}_{\mathrm{DD}} \\ & \mathrm{I}_{\mathrm{SD}}=10 \mathrm{~mA} \end{aligned}$ <br> Refer to On-Resistance | $25^{\circ} \mathrm{C}$ |  | 0.85 |  | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 1.6 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 1.6 | $\Omega$ |
| $\mathrm{I}_{\text {(OFF) }}$ | Source off leakage current ${ }^{(1)}$ | $\mathrm{V}_{\mathrm{DD}}=+2.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{SS}}=-2.5 \mathrm{~V}$ <br> Switch Off $\begin{aligned} & V_{D}=+2 \mathrm{~V} /-1 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{S}}=-1 \mathrm{~V} /+2 \mathrm{~V} \end{aligned}$ <br> Refer to Off-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.08 | $\pm 0.005$ | 0.08 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.3 |  | 0.3 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -0.9 |  | 0.9 | nA |
| $\mathrm{Id}_{\text {(OFF) }}$ | Drain off leakage current ${ }^{(1)}$ | $\mathrm{V}_{\mathrm{DD}}=+2.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{SS}}=-2.5 \mathrm{~V}$ <br> Switch Off $\begin{aligned} & V_{D}=+2 V /-1 V \\ & V_{S}=-1 V /+2 V \end{aligned}$ <br> Refer to Off-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.1 | $\pm 0.01$ | 0.1 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.75 |  | 0.75 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -3.5 |  | 3.5 | nA |
| $\mathrm{I}_{\mathrm{D}(\mathrm{ON})}$ $\mathrm{I}_{\mathrm{S}(\mathrm{ON})}$ | Channel on leakage current | $\mathrm{V}_{\mathrm{DD}}=+2.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{SS}}=-2.5 \mathrm{~V}$ <br> Switch On $V_{D}=V_{S}=+2 V /-1 V$ <br> Refer to On-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.1 | $\pm 0.01$ | 0.1 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.75 |  | 0.75 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -3 |  | 3 | nA |
| LOGIC INPUTS (EN, A0, A1) |  |  |  |  |  |  |  |
| $\mathrm{V}_{\mathrm{IH}}$ | Input logic high |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 1.2 |  | 2.75 | V |
| $\mathrm{V}_{\text {IL }}$ | Input logic low |  |  | 0 |  | 0.73 | V |
| $\begin{array}{\|l\|l\|} \hline I_{\mathrm{H}} \\ \mathrm{I}_{\mathrm{L}} \\ \hline \end{array}$ | Input leakage current |  | $25^{\circ} \mathrm{C}$ |  | $\pm 0.005$ |  | $\mu \mathrm{A}$ |
| $\begin{array}{\|l} \hline I_{\mathrm{IH}} \\ \mathrm{I}_{\mathrm{L}} \\ \hline \end{array}$ | Input leakage current |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | $\pm 0.05$ | $\mu \mathrm{A}$ |
| $\mathrm{C}_{\text {IN }}$ | Logic input capacitance |  | $25^{\circ} \mathrm{C}$ |  | 1 |  | pF |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 2 | pF |
| POWER SUPPLY |  |  |  |  |  |  |  |
| $\mathrm{I}_{\mathrm{DD}}$ | $\mathrm{V}_{\mathrm{DD}}$ supply current | Logic inputs $=0 \mathrm{~V}$ or 2.75 V | $25^{\circ} \mathrm{C}$ |  | 0.008 |  | $\mu \mathrm{A}$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 1 | $\mu \mathrm{A}$ |
| Iss | $\mathrm{V}_{\text {SS }}$ supply current | Logic inputs $=0 \mathrm{~V}$ or 2.75 V | $25^{\circ} \mathrm{C}$ |  | 0.008 |  | $\mu \mathrm{A}$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 1 | $\mu \mathrm{A}$ |

(1) When $V_{S}$ is positive, $V_{D}$ is negative, and vice versa.

## Electrical Characteristics ( $\left.\mathrm{V}_{\mathrm{DD}}=2.5 \mathrm{~V} \pm 10 \%\right)$, $\left(\mathrm{V}_{\mathrm{SS}}=\mathbf{- 2 . 5} \mathrm{V} \pm 10 \%\right.$ ) (continued)

at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{DD}}=+2.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{SS}}=-2.5 \mathrm{~V}$ (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS | TA | MIN TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DYNAMIC CHARACTERISTICS |  |  |  |  |  |  |
| ${ }^{\text {tran }}$ | Transition time between channels | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=1.5 \mathrm{~V} \\ & \mathrm{R}_{\mathrm{L}}=200 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF} \\ & \text { Refer to Transition Time } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 14 |  | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  | 21 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  | 21 | ns |
| topen (BBM) | Break before make time | $\begin{aligned} & V_{S}=1.5 \mathrm{~V} \\ & R_{L}=200 \Omega, C_{L}=15 \mathrm{pF} \end{aligned}$ <br> Refer to Break-Before-Make | $25^{\circ} \mathrm{C}$ | 8 |  | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 1 |  | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 1 |  | ns |
| ton(EN) | Enable turn-on time | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=1.5 \mathrm{~V} \\ & \mathrm{R}_{\mathrm{L}}=200 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF} \\ & \text { Refer to } \mathrm{t}_{\mathrm{ON}(\mathrm{EN})} \text { and } \mathrm{t}_{\mathrm{OFF}(\mathrm{EN})} \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 14 |  | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  | 21 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  | 22 | ns |
| toff(EN) | Enable turn-off time | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=1.5 \mathrm{~V} \\ & \mathrm{R}_{\mathrm{L}}=200 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF} \\ & \text { Refer to ton(EN) and toff(EN) } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 8 |  | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  | 11 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  | 12 | ns |
| $\mathrm{Q}_{\mathrm{C}}$ | Charge Injection | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=-1 \mathrm{~V} \\ & \mathrm{R}_{\mathrm{S}}=0 \Omega, \mathrm{C}_{\mathrm{L}}=1 \mathrm{nF} \end{aligned}$ <br> Refer to Charge Injection | $25^{\circ} \mathrm{C}$ | -1 |  | pC |
| $\mathrm{O}_{\text {ISO }}$ | Off Isolation | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF} \\ & \mathrm{f}=1 \mathrm{MHz} \end{aligned}$ Refer to Off Isolation | $25^{\circ} \mathrm{C}$ | -65 |  | dB |
|  |  | $\begin{aligned} & R_{L}=50 \Omega, C_{L}=5 \mathrm{pF} \\ & \mathrm{f}=10 \mathrm{MHz} \\ & \text { Refer to Off Isolation } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | -45 |  | dB |
| $\mathrm{X}_{\text {taLk }}$ | Crosstalk | $\begin{aligned} & R_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF} \\ & \mathrm{f}=1 \mathrm{MHz} \\ & \text { Refer to Crosstalk } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | -90 |  | dB |
|  |  | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF} \\ & \mathrm{f}=10 \mathrm{MHz} \\ & \text { Refer to Crosstalk } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | -80 |  | dB |
| BW | Bandwidth | $\mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF}$ <br> Refer to Bandwidth | $25^{\circ} \mathrm{C}$ | 135 |  | MHz |
| C Soff | Source off capacitance | $\mathrm{f}=1 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 7 |  | pF |
| $\mathrm{C}_{\text {dofF }}$ | Drain off capacitance | $\mathrm{f}=1 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 32 |  | pF |
| Cson Con | On capacitance | $\mathrm{f}=1 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 38 |  | pF |

### 6.8 Electrical Characteristics ( $\mathrm{V}_{\mathrm{DD}}=1.8 \mathrm{~V} \pm 10 \%$ )

at $T_{A}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{DD}}=1.8 \mathrm{~V}$ (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS | TA | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG SWITCH |  |  |  |  |  |  |  |
| $\mathrm{R}_{\text {ON }}$ | On-resistance | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=0 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{DD}} \\ & \mathrm{I}_{\mathrm{SD}}=10 \mathrm{~mA} \\ & \text { Refer to On-Resistance } \end{aligned}$ | $25^{\circ} \mathrm{C}$ |  | 40 |  | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 80 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 80 | $\Omega$ |
| $\Delta \mathrm{R}_{\text {ON }}$ | On-resistance matching between channels | $\begin{aligned} & V_{S}=0 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{DD}} \\ & \mathrm{I}_{\mathrm{SD}}=10 \mathrm{~mA} \end{aligned}$ <br> Refer to On-Resistance | $25^{\circ} \mathrm{C}$ |  | 0.4 |  | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 1.5 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 1.5 | $\Omega$ |
| $\mathrm{I}_{\text {S(OFF) }}$ | Source off leakage current ${ }^{(1)}$ | $\mathrm{V}_{\mathrm{DD}}=1.98 \mathrm{~V}$ <br> Switch Off $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=1.62 \mathrm{~V} / 1 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{S}}=1 \mathrm{~V} / 1.62 \mathrm{~V} \end{aligned}$ <br> Refer to Off-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.05 | $\pm 0.003$ | 0.05 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.1 |  | 0.1 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -0.5 |  | 0.5 | nA |
| $\mathrm{I}_{\text {( OFF) }}$ | Drain off leakage current ${ }^{(1)}$ | $\mathrm{V}_{\mathrm{DD}}=1.98 \mathrm{~V}$ <br> Switch Off $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=1.62 \mathrm{~V} / 1 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{S}}=1 \mathrm{~V} / 1.62 \mathrm{~V} \end{aligned}$ <br> Refer to Off-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.1 | $\pm 0.005$ | 0.1 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.5 |  | 0.5 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -2 |  | 2 | nA |
| $\mathrm{I}_{\mathrm{D}(\mathrm{ON})}$ <br> $\mathrm{I}_{\mathrm{S}(\mathrm{ON})}$ | Channel on leakage current | $V_{D D}=1.98 \mathrm{~V}$ <br> Switch On $V_{D}=V_{S}=1.62 \mathrm{~V} / 1 \mathrm{~V}$ <br> Refer to On-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.1 | $\pm 0.005$ | 0.1 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.5 |  | 0.5 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -2 |  | 2 | nA |
| LOGIC INPUTS (EN, A0, A1) |  |  |  |  |  |  |  |
| $\mathrm{V}_{\mathrm{IH}}$ | Input logic high |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 1.07 |  | 5.5 | V |
| $\mathrm{V}_{\mathrm{IL}}$ | Input logic low |  |  | 0 |  | 0.68 | V |
| $\begin{array}{\|l}  \\ \mathrm{I}_{\mathrm{H}} \\ \mathrm{I}_{\mathrm{L}} \\ \hline \end{array}$ | Input leakage current |  | $25^{\circ} \mathrm{C}$ |  | $\pm 0.005$ |  | $\mu \mathrm{A}$ |
| $\begin{array}{\|l} \hline \mathrm{I}_{\mathrm{H}} \\ \mathrm{I}_{\mathrm{L}} \\ \hline \end{array}$ | Input leakage current |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | $\pm 0.05$ | $\mu \mathrm{A}$ |
| $\mathrm{C}_{\text {IN }}$ | Logic input capacitance |  | $25^{\circ} \mathrm{C}$ |  | 1 |  | pF |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 2 | pF |
| POWER SUPPLY |  |  |  |  |  |  |  |
| IDD | $V_{\text {DD }}$ supply current | Logic inputs $=0 \mathrm{~V}$ or 5.5 V | $25^{\circ} \mathrm{C}$ |  | 0.001 |  | $\mu \mathrm{A}$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 0.85 | $\mu \mathrm{A}$ |

(1) When $\mathrm{V}_{\mathrm{S}}$ is $1.62 \mathrm{~V}, \mathrm{~V}_{\mathrm{D}}$ is 1 V , and vice versa.

## Electrical Characteristics ( $\mathrm{V}_{\mathrm{DD}}=1.8 \mathrm{~V} \pm 10 \%$ ) (continued)

at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{DD}}=1.8 \mathrm{~V}$ (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS | TA | MIN TYP MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| DYNAMIC CHARACTERISTICS |  |  |  |  |  |
| $t_{\text {tran }}$ | Transition time between channels | $\begin{aligned} & V_{S}=1 \mathrm{~V} \\ & R_{L}=200 \Omega, C_{L}=15 \mathrm{pF} \end{aligned}$Refer to Transition Time | $25^{\circ} \mathrm{C}$ | 28 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 48 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 48 | ns |
| topen (BBM) | Break before make time | $\begin{aligned} & V_{S}=1 \mathrm{~V} \\ & R_{L}=200 \Omega, C_{L}=15 \mathrm{pF} \end{aligned}$ <br> Refer to Break-Before-Make | $25^{\circ} \mathrm{C}$ | 16 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 1 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 1 | ns |
| ton(EN) | Enable turn-on time | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=1 \mathrm{~V} \\ & \mathrm{R}_{\mathrm{L}}=200 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF} \\ & \text { Refer to } \mathrm{t}_{\mathrm{ON}(\mathrm{EN})} \text { and } \mathrm{t}_{\mathrm{OFF}(\mathrm{EN})} \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 28 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 48 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 48 | ns |
| toff(EN) | Enable turn-off time | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=1 \mathrm{~V} \\ & \mathrm{R}_{\mathrm{L}}=200 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF} \\ & \text { Refer to toN(EN) and tofF(EN) } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 16 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 27 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 27 | ns |
| $Q_{C}$ | Charge Injection | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=1 \mathrm{~V} \\ & \mathrm{R}_{\mathrm{S}}=0 \Omega, \mathrm{C}_{\mathrm{L}}=1 \mathrm{nF} \end{aligned}$ <br> Refer to Charge Injection | $25^{\circ} \mathrm{C}$ | -0.5 | pC |
| $\mathrm{O}_{\text {ISO }}$ | Off Isolation | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF} \\ & \mathrm{f}=1 \mathrm{MHz} \\ & \text { Refer to Off Isolation } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | -65 | dB |
|  |  | $\begin{aligned} & R_{\mathrm{L}}=50 \Omega, C_{L}=5 \mathrm{pF} \\ & \mathrm{f}=10 \mathrm{MHz} \\ & \text { Refer to Off Isolation } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | -45 | dB |
| $\mathrm{X}_{\text {taLk }}$ | Crosstalk | $\begin{aligned} & R_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF} \\ & \mathrm{f}=1 \mathrm{MHz} \\ & \text { Refer to Crosstalk } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | -90 | dB |
|  |  | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF} \\ & \mathrm{f}=10 \mathrm{MHz} \\ & \text { Refer to Crosstalk } \end{aligned}$ | $25^{\circ} \mathrm{C}$ | -80 | dB |
| BW | Bandwidth | $\mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF}$ <br> Refer to Bandwidth | $25^{\circ} \mathrm{C}$ | 135 | MHz |
| CSOFF | Source off capacitance | $\mathrm{f}=1 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 7 | pF |
| C ${ }_{\text {dofF }}$ | Drain off capacitance | $\mathrm{f}=1 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 32 | pF |
| Cson CDON | On capacitance | $\mathrm{f}=1 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 38 | pF |

### 6.9 Electrical Characteristics ( $\mathrm{V}_{\mathrm{DD}}=1.2 \mathrm{~V} \pm 10 \%$ )

| PARAMETER |  | TEST CONDITIONS | TA | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG SWITCH |  |  |  |  |  |  |  |
| $\mathrm{R}_{\mathrm{ON}}$ | On-resistance | $\begin{aligned} & V_{S}=0 \mathrm{~V} \text { to } V_{D D} \\ & I_{S D}=10 \mathrm{~mA} \end{aligned}$ <br> Refer to On-Resistance | $25^{\circ} \mathrm{C}$ |  | 70 |  | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 105 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 105 | $\Omega$ |
| $\Delta \mathrm{R}_{\text {ON }}$ | On-resistance matching between channels | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=0 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{DD}} \\ & \mathrm{I}_{\mathrm{SD}}=10 \mathrm{~mA} \end{aligned}$ <br> Refer to On-Resistance | $25^{\circ} \mathrm{C}$ |  | 0.4 |  | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  | 1.5 | $\Omega$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 1.5 | $\Omega$ |
| $\mathrm{I}_{\text {S(OFF) }}$ | Source off leakage current ${ }^{(1)}$ | $V_{D D}=1.32 \mathrm{~V}$ <br> Switch Off $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=1 \mathrm{~V} / 0.8 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{S}}=0.8 \mathrm{~V} / 1 \mathrm{~V} \end{aligned}$ <br> Refer to Off-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.05 | $\pm 0.003$ | 0.05 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.1 |  | 0.1 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -0.5 |  | 0.5 | nA |
| $\mathrm{I}_{\text {( OFF) }}$ | Drain off leakage current ${ }^{(1)}$ | $V_{D D}=1.32 \mathrm{~V}$ <br> Switch Off $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=1 \mathrm{~V} / 0.8 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{S}}=0.8 \mathrm{~V} / 1 \mathrm{~V} \end{aligned}$ <br> Refer to Off-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.1 | $\pm 0.005$ | 0.1 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.5 |  | 0.5 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -2 |  | 2 | nA |
| $\mathrm{I}_{\mathrm{D}(\mathrm{ON})}$ $\mathrm{I}_{\mathrm{S}(\mathrm{ON})}$ | Channel on leakage current | $V_{D D}=1.32 \mathrm{~V}$ <br> Switch On $V_{D}=V_{S}=1 \mathrm{~V} / 0.8 \mathrm{~V}$ <br> Refer to On-Leakage Current | $25^{\circ} \mathrm{C}$ | -0.1 | $\pm 0.005$ | 0.1 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | -0.5 |  | 0.5 | nA |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -2 |  | 2 | nA |
| LOGIC INPUTS (EN, A0, A1) |  |  |  |  |  |  |  |
| $\mathrm{V}_{\mathrm{IH}}$ | Input logic high |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 0.96 |  | 5.5 | V |
| $\mathrm{V}_{\text {IL }}$ | Input logic low |  |  | 0 |  | 0.36 | V |
| $\begin{aligned} & \mathrm{I}_{\mathrm{HH}} \\ & \mathrm{I}_{\mathrm{IL}} \end{aligned}$ | Input leakage current |  | $25^{\circ} \mathrm{C}$ |  | $\pm 0.005$ |  | $\mu \mathrm{A}$ |
| $\begin{aligned} & \mathrm{I}_{\mathrm{IH}} \\ & \mathrm{I}_{\mathrm{IL}} \end{aligned}$ | Input leakage current |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | $\pm 0.05$ | $\mu \mathrm{A}$ |
| $\mathrm{C}_{\text {IN }}$ | Logic input capacitance |  | $25^{\circ} \mathrm{C}$ |  | 1 |  | pF |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 2 | pF |
| POWER SUPPLY |  |  |  |  |  |  |  |
| IDD | $\mathrm{V}_{\mathrm{DD}}$ supply current | Logic inputs $=0 \mathrm{~V}$ or 5.5 V | $25^{\circ} \mathrm{C}$ |  | 0.001 |  | $\mu \mathrm{A}$ |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  | 0.7 | $\mu \mathrm{A}$ |

[^1]
## Electrical Characteristics ( $\mathrm{V}_{\mathrm{DD}}=1.2 \mathrm{~V} \pm 10 \%$ ) (continued)

|  | PARAMETER | TEST CONDITIONS | TA | MIN | TYP MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DYNAMIC CHARACTERISTICS |  |  |  |  |  |  |
| $t_{\text {tran }}$ | Transition time between channels | $\begin{aligned} & V_{S}=1 \mathrm{~V} \\ & R_{L}=200 \Omega, C_{L}=15 \mathrm{pF} \end{aligned}$Refer to Transition Time | $25^{\circ} \mathrm{C}$ |  | 60 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  | 210 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  | 210 | ns |
| topen(BBM) | Break before make time | $\begin{aligned} & V_{S}=1 \mathrm{~V} \\ & R_{L}=200 \Omega, C_{L}=15 \mathrm{pF} \end{aligned}$Refer to Break-Before-Make | $25^{\circ} \mathrm{C}$ |  | 28 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 1 |  | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | 1 |  | ns |
| ton(EN) | Enable turn-on time | $\begin{aligned} & V_{S}=1 \mathrm{~V} \\ & R_{L}=200 \Omega, C_{L}=15 \mathrm{pF} \end{aligned}$ <br> Refer to $\mathrm{t}_{\mathrm{ON}(\mathrm{EN})}$ and $\mathrm{t}_{\mathrm{OFF}}(\mathrm{EN})$ | $25^{\circ} \mathrm{C}$ |  | 60 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  | 190 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  | 190 | ns |
| toff(EN) | Enable turn-off time | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}=1 \mathrm{~V} \\ & \mathrm{R}_{\mathrm{L}}=200 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF} \\ & \text { Refer to toN(EN) and tofF(EN) } \end{aligned}$ | $25^{\circ} \mathrm{C}$ |  | 45 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  | 150 | ns |
|  |  |  | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  | 150 | ns |
| $Q_{C}$ | Charge Injection | $\begin{array}{\|l} \hline \mathrm{V}_{\mathrm{S}}=1 \mathrm{~V} \\ \mathrm{R}_{\mathrm{S}}=0 \Omega, \mathrm{C}_{\mathrm{L}}=1 \mathrm{nF} \\ \text { Refer to Charge Injection } \\ \hline \end{array}$ | $25^{\circ} \mathrm{C}$ |  | -0.5 | pC |
| Oiso | Off Isolation | $\begin{aligned} & R_{\mathrm{L}}=50 \Omega, C_{\mathrm{L}}=5 \mathrm{pF} \\ & \mathrm{f}=1 \mathrm{MHz} \\ & \text { Refer to Off Isolation } \end{aligned}$ | $25^{\circ} \mathrm{C}$ |  | -65 | dB |
|  |  | $\begin{aligned} & R_{L}=50 \Omega, C_{L}=5 \mathrm{pF} \\ & \mathrm{f}=10 \mathrm{MHz} \\ & \text { Refer to Off Isolation } \end{aligned}$ | $25^{\circ} \mathrm{C}$ |  | -45 | dB |
| $\mathrm{X}_{\text {TALK }}$ | Crosstalk | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF} \\ & \mathrm{f}=1 \mathrm{MHz} \\ & \text { Refer to Crosstalk } \\ & \hline \end{aligned}$ | $25^{\circ} \mathrm{C}$ |  | -90 | dB |
|  |  | $\begin{array}{\|l} \hline \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF} \\ \mathrm{f}=10 \mathrm{MHz} \\ \text { Refer to Crosstalk } \\ \hline \end{array}$ | $25^{\circ} \mathrm{C}$ |  | -80 | dB |
| BW | Bandwidth | $\mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF}$ <br> Refer to Bandwidth | $25^{\circ} \mathrm{C}$ |  | 135 | MHz |
| $\mathrm{C}_{\text {SOFF }}$ | Source off capacitance | $\mathrm{f}=1 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ |  | 7 | pF |
| $\mathrm{C}_{\text {DOFF }}$ | Drain off capacitance | $\mathrm{f}=1 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ |  | 32 | pF |
| Cson Con | On capacitance | $\mathrm{f}=1 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ |  | 38 | pF |

### 6.10 Typical Characteristics

at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}$ (unless otherwise noted)

$\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$
Figure 1. On-Resistance vs Source or Drain Voltage

$\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$
Figure 3. On-Resistance vs Source or Drain Voltage


Figure 5. On-Resistance vs Source or Drain Voltage


Figure 2. On-Resistance vs Temperature

$\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}$
Figure 4. On-Resistance vs Temperature


Figure 6. On-Leakage vs Source or Drain Voltage

## Typical Characteristics (continued)



Figure 7. On-Leakage vs Source or Drain Voltage


Figure 9. Leakage Current vs Temperature


Figure 11. Supply Current vs Logic Voltage


Figure 8. Leakage Current vs Temperature


Figure 10. Supply Current vs Temperature

$\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$
Figure 12. Charge Injection vs Source or Drain Voltage

## Typical Characteristics (continued)



Figure 13. Charge Injection vs Source or Drain Voltage


Figure 15. $\mathrm{T}_{\mathrm{ON} \text { (EN) }}$ and $\mathrm{T}_{\mathrm{OFF} \text { (EN) }}$ vs Temperature


Figure 14. $\mathrm{T}_{\mathrm{ON}(E N)}$ and $\mathrm{T}_{\mathrm{OFF}(\mathrm{EN})}$ vs Supply Voltage


$$
\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}
$$

Figure 16. Ttransition vs Supply Voltage


$$
\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}
$$

Figure 17. Frequency Response

## 7 Detailed Description

### 7.1 Overview

### 7.1.1 On-Resistance

The on-resistance of a device is the ohmic resistance between the source (Sx) and drain (D) pins of the device. The on-resistance varies with input voltage and supply voltage. The symbol $\mathrm{R}_{\mathrm{ON}}$ is used to denote on-resistance. The measurement setup used to measure $\mathrm{R}_{\mathrm{ON}}$ is shown in Figure 18. Voltage $(\mathrm{V})$ and current ( $\mathrm{I}_{\mathrm{SD}}$ ) are measured using this setup, and $\mathrm{R}_{\mathrm{ON}}$ is computed with $\mathrm{R}_{\mathrm{ON}}=\mathrm{V} / \mathrm{I}_{\mathrm{SD}}$ :


Figure 18. On-Resistance Measurement Setup

### 7.1.2 Off-Leakage Current

There are two types of leakage currents associated with a switch during the off state:

1. Source off-leakage current
2. Drain off-leakage current

Source leakage current is defined as the leakage current flowing into or out of the source pin when the switch is off. This current is denoted by the symbol $\mathrm{I}_{\mathrm{S}(\mathrm{OFF})}$.
Drain leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is off. This current is denoted by the symbol $\mathrm{I}_{\mathrm{D}(\mathrm{OFF})}$.
The setup used to measure both off-leakage currents is shown in Figure 19.


Figure 19. Off-Leakage Measurement Setup

## Overview (continued)

### 7.1.3 On-Leakage Current

Source on-leakage current is defined as the leakage current flowing into or out of the source pin when the switch is on. This current is denoted by the symbol $\mathrm{I}_{(\mathrm{ON})}$.
Drain on-leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is on. This current is denoted by the symbol $\mathrm{I}_{\mathrm{D}(\mathrm{ON})}$.
Either the source pin or drain pin is left floating during the measurement. Figure 20 shows the circuit used for measuring the on-leakage current, denoted by $\mathrm{I}_{\mathrm{S}(\mathrm{ON})}$ or $\mathrm{I}_{\mathrm{D}(\mathrm{ON})}$.


Figure 20. On-Leakage Measurement Setup

### 7.1.4 Transition Time

Transition time is defined as the time taken by the output of the device to rise or fall $10 \%$ after the address signal has risen or fallen past the logic threshold. The $10 \%$ transition measurement is utilized to provide the timing of the device, system level timing can then account for the time constant added from the load resistance and load capacitance. Figure 21 shows the setup used to measure transition time, denoted by the symbol t transition.


Figure 21. Transition-Time Measurement Setup

## Overview (continued)

### 7.1.5 Break-Before-Make

Break-before-make delay is a safety feature that prevents two inputs from connecting when the device is switching. The output first breaks from the on-state switch before making the connection with the next on-state switch. The time delay between the break and the make is known as break-before-make delay. Figure 22 shows the setup used to measure break-before-make delay, denoted by the symbol $\mathrm{t}_{\text {OPEN(BBM) }}$.


Figure 22. Break-Before-Make Delay Measurement Setup

### 7.1.6 $t_{\text {ON(EN) }}$ and $\mathrm{t}_{\mathrm{OFF}(E \mathrm{~N})}$

Turn-on time is defined as the time taken by the output of the device to rise to $10 \%$ after the enable has risen past the logic threshold. The 10\% measurement is utilized to provide the timing of the device, system level timing can then account for the time constant added from the load resistance and load capacitance. Figure 23 shows the setup used to measure turn-on time, denoted by the symbol $\mathrm{t}_{\mathrm{ON}(\mathrm{EN})}$.
Turn-off time is defined as the time taken by the output of the device to fall to $90 \%$ after the enable has fallen past the logic threshold. The $90 \%$ measurement is utilized to provide the timing of the device, system level timing can then account for the time constant added from the load resistance and load capacitance. Figure 23 shows the setup used to measure turn-off time, denoted by the symbol $\mathrm{t}_{\mathrm{OFF}(\mathrm{EN})}$.


Figure 23. Turn-On and Turn-Off Time Measurement Setup

## Overview (continued)

### 7.1.7 Charge Injection

The TMUX1109 has a transmission-gate topology. Any mismatch in capacitance between the NMOS and PMOS transistors results in a charge injected into the drain or source during the falling or rising edge of the gate signal. The amount of charge injected into the source or drain of the device is known as charge injection, and is denoted by the symbol $Q_{c}$. Figure 24 shows the setup used to measure charge injection from source (Sx) to drain (D).


Figure 24. Charge-Injection Measurement Setup

### 7.1.8 Off Isolation

Off isolation is defined as the ratio of the signal at the drain pin (D) of the device when a signal is applied to the source pin (Sx) of an off-channel. Figure 25 shows the setup used to measure and the equation used to compute off isolation.


Figure 25. Off Isolation Measurement Setup

$$
\begin{equation*}
\text { Off Isolation }=20 \cdot \log \left(\frac{\mathrm{~V}_{\mathrm{OUT}}}{\mathrm{~V}_{\mathrm{S}}}\right) \tag{1}
\end{equation*}
$$

## Overview (continued)

### 7.1.9 Crosstalk

Crosstalk is defined as the ratio of the signal at the drain pin (D) of a different channel, when a signal is applied at the source pin ( Sx ) of an on-channel. Figure 26 shows the setup used to measure, and the equation used to compute crosstalk.


Figure 26. Crosstalk Measurement Setup

$$
\begin{equation*}
\text { Channel-to-Channel Crosstalk }=20 \cdot \log \left(\frac{\mathrm{~V}_{\mathrm{OUT}}}{\mathrm{~V}_{\mathrm{S}}}\right) \tag{2}
\end{equation*}
$$

### 7.1.10 Bandwidth

Bandwidth is defined as the range of frequencies that are attenuated by less than 3 dB when the input is applied to the source pin (Sx) of an on-channel, and the output is measured at the drain pin (D) of the device. Figure 27 shows the setup used to measure bandwidth.


Figure 27. Bandwidth Measurement Setup

### 7.2 Functional Block Diagram

The TMUX1109 is an 4:1, differential (2-channel), multiplexer. Each switch is turned on or off based on the state of the address lines and enable pin.


Figure 28. TMUX1109 Functional Block Diagram

### 7.3 Feature Description

### 7.3.1 Bidirectional Operation

The TMUX1109 conducts equally well from source (Sx) to drain (Dx) or from drain (Dx) to source (Sx). Each channel has very similar characteristics in both directions and supports both analog and digital signals.

### 7.3.2 Rail to Rail Operation

The valid signal path input/output voltage for TMUX1109 ranges from $\mathrm{V}_{\text {SS }}$ to $\mathrm{V}_{\mathrm{DD}}$.

### 7.3.3 1.8 V Logic Compatible Inputs

The TMUX1109 has 1.8-V logic compatible control for all logic control inputs. The logic input thresholds scale with supply but still provide $1.8-\mathrm{V}$ logic control when operating at 5.5 V supply voltage. $1.8-\mathrm{V}$ logic level inputs allows the TMUX1109 to interface with processors that have lower logic I/O rails and eliminates the need for an external translator, which saves both space and BOM cost. For more information on 1.8 V logic implementations refer to Simplifying Design with 1.8 V logic Muxes and Switches

### 7.3.4 Fail-Safe Logic

The TMUX1109 supports Fail-Safe Logic on the control input pins (EN, A0, A1) allowing for operation up to 5.5 V above $\mathrm{V}_{\text {SS }}$, regardless of the state of the supply pin. This feature allows voltages on the control pins to be applied before the supply pin, protecting the device from potential damage. Fail-Safe Logic minimizes system complexity by removing the need for power supply sequencing on the logic control pins. For example, the Fail-Safe Logic feature allows the select pins of the TMUX1109 to be ramped to 5.5 V while $\mathrm{V}_{\mathrm{DD}}=0 \mathrm{~V}$. Additionally, the feature enables operation of the TMUX1109 with $\mathrm{V}_{\mathrm{DD}}=1.2 \mathrm{~V}$ while allowing the select pins to interface with a logic level of another device up to 5.5 V .

## Feature Description (continued)

### 7.3.5 Ultra-low Leakage Current

The TMUX1109 provides extremely low on-leakage and off-leakage currents. The TMUX1109 is capable of switching signals from high source-impedance inputs into a high input-impedance op amp with minimal offset error because of the ultralow leakage currents. Figure 29 shows typical leakage currents of the TMUX1109 versus temperature.


Figure 29. Leakage Current vs Temperature

### 7.3.6 Ultra-low Charge Injection

The TMUX1109 has a transmission gate topology, as shown in Figure 30. Any mismatch in the stray capacitance associated with the NMOS and PMOS causes an output level change whenever the switch is opened or closed.


Figure 30. Transmission Gate Topology
The TMUX1109 has special charge-injection cancellation circuitry that reduces the source-to-drain charge injection to as low as 1 pC at $\mathrm{V}_{\mathrm{S}}=1 \mathrm{~V}$ as shown in Figure 31.

## Feature Description (continued)



Figure 31. Charge Injection vs Source Voltage

### 7.4 Device Functional Modes

When the EN pin of the TMUX1109 is pulled high, one of the switches is closed based on the state of the address lines. When the EN pin is pulled low, all the switches are in an open state regardless of the state of the address lines.

### 7.4.1 Truth Tables

Table 1. TMUX1109 Truth Table

| EN | A1 | A0 | Selected Input Connected To Drain (DA, DB) Pins |
| :---: | :---: | :---: | :---: |
| 0 | $\mathrm{X}^{(1)}$ | $\mathrm{X}^{(1)}$ | All channels are off |
| 1 | 0 | 0 | S1A and S1B |
| 1 | 0 | 1 | S2A and S2B |
| 1 | 1 | 0 | S3A and S3B |
| 1 | 1 | 1 | S4A and S4B |

(1) $X$ denotes don't care.

## 8 Application and Implementation

## NOTE

Information in the following applications sections is not part of the Tl component specification, and TI does not warrant its accuracy or completeness. Tl's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 8.1 Application Information

The TMUX11xx family offers ulta-low input/output leakage currents and low charge injection. These devices operate up to 5.5 V , and offer true rail-to-rail input and output. The TMUX1109 has a low on-capacitance which allows faster settling time when multiplexing inputs in the time domain. These features make the TMUX11xx devices a family of precision, robust, high-performance analog multiplexer for low-voltage applications.

### 8.2 Typical Application

Figure 32 shows a 16-bit, simultaneous-sampling data-acquisition system. This example is typical in industrial applications that require sampling simultaneous signals such as Optical Modules, Analog Input Modules, and Motor Drive circuits for position feedback. The circuit uses eight Fully Differential Amplifiers (FDAs), a 16-bit, 3MSPS successive-approximation-resistor (SAR) analog-to-digital converter (ADC), along with a two differential precision multiplexers. Refer to True Differential, $4 \times 2$ MUX, Analog Front End, Simultaneous-Sampling ADC Circuit for more information.


Figure 32. Simultaneous-Sampling ADC Circuit

### 8.3 Design Requirements

For this design example, use the parameters listed in Table 2.
Table 2. Design Parameters

| PARAMETERS | VALUES |
| :---: | :---: |
| Supply (VD) | 5 V |
| Vref | 4.096 V |
| Vocm | 2.048 V |
| Max Differential Voltage | 3.636 V |
| Control logic thresholds | 1.8 V compatible |

### 8.4 Detailed Design Procedure

The TMUX1109 can be operated without any external components except for the supply decoupling capacitors. If the device desired power-up state is disabled, the enable pin should have a weak pull-down resistor and be controlled by the MCU via GPIO. All inputs being muxed to the ADC must fall within the recommend operating conditions of the TMUX1109 including signal range and continuous current. System level design and component selection are made according to True Differential, $4 \times 2$ MUX, Analog Front End, Simultaneous-Sampling ADC Circuit.

1. The ADS9224R was selected because of the dual simultaneous sampling and high throughput (3-MSPS).
2. The TMUX1109 4:1 (2x) multiplexer was selected to support 4 differential inputs for each ADC.
3. Find ADC full-scale range, resolution and common-mode range specifications.
4. Determine the linear range of the FDA (THS4551) based on common-mode and output swing specification.
5. Select COG capacitors for all filter capacitors at the ADC input to minimize distortion.
6. Select the FDA gain resistors RF1,2, RG1,2. Use $0.1 \% 20 \mathrm{ppm} /{ }^{\circ} \mathrm{C}$ film resistors or better for good accuracy, low gain drift and to minimize distortion.
7. Introduction to SAR ADC Front-End Component Selection covers the methods for selecting the charge bucket circuit Rfil1, Rfil1 and Cfil. These component values are dependent on the amplifier bandwidth, data converter sampling rare, and data converter design. The values shown here will give good settling and AC performance for the amplifier and data converter in this example. If the design is modified, a different RC filter must be selected.
8. The THS4551 is commonly used in high-speed precision fully differential SAR applications as it has sufficient bandwidth to settle to charge kickback transients from the ADC input sampling, and multiplexer charge injection and provides the common-mode level shifting to the voltage range of the SAR ADC.
9. The TMUX1109 is used in high-speed precision fully differential SAR applications as it has sufficient bandwidth, low charge injection, and low on-resistance and capacitance. Low capacitance supports fast switching between channels and allows the system to settle within required precision in the specified timing.

### 8.5 Application Curve

Charge injection impacts system performance and settling characteristics of the charge bucket circuit. A multiplexer with low charge injection and a flat response across input voltage allows the system to settle to the required precision during the ADC acquisition period. Figure 33 shows the flat charge injection of the TMUX1109 at multiple supply voltages.


Figure 33. Charge Injection vs Source Voltage

## 9 Power Supply Recommendations

The TMUX1109 operates across a wide supply range of 1.08 V to 5.5 V , or $\pm 2.5 \mathrm{~V}$. Do not exceed the absolute maximum ratings because stresses beyond the listed ratings can cause permanent damage to the devices.

Power-supply bypassing improves noise margin and prevents switching noise propagation from the $\mathrm{V}_{\mathrm{DD}}$ and ss supplies to other components. Good power-supply decoupling is important to achieve optimum performance. For improved supply noise immunity, use a supply decoupling capacitor ranging from $0.1 \mu \mathrm{~F}$ to $10 \mu \mathrm{~F}$ from $\mathrm{V}_{\mathrm{DD}}$ and $\mathrm{V}_{\mathrm{SS}}$ to ground. Place the bypass capacitors as close to the power supply pins of the device as possible using low-impedance connections. TI recommends using multi-layer ceramic chip capacitors (MLCCs) that offer low equivalent series resistance (ESR) and inductance (ESL) characteristics for power-supply decoupling purposes. For very sensitive systems, or for systems in harsh noise environments, avoiding the use of vias for connecting the capacitors to the device pins may offer superior noise immunity. The use of multiple vias in parallel lowers the overall inductance and is beneficial for connections to ground planes.

## 10 Layout

### 10.1 Layout Guidelines

### 10.1.1 Layout Information

When a PCB trace turns a corner at a $90^{\circ}$ angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self-inductance of the trace which results in the reflection. Not all PCB traces can be straight and therefore some traces must turn corners.Figure 34 shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.


Figure 34. Trace Example
Route high-speed signals using a minimum of vias and corners which reduces signal reflections and impedance changes. When a via must be used, increase the clearance size around it to minimize its capacitance. Each via introduces discontinuities in the signal's transmission line and increases the chance of picking up interference from the other layers of the board. Be careful when designing test points, throughhole pins are not recommended at high frequencies.

Figure 35 illustrates an example of a PCB layout with the TMUX1109. Some key considerations are:

- Decouple the $V_{D D}$ pin with a $0.1-\mu \mathrm{F}$ capacitor, placed as close to the pin as possible. Make sure that the capacitor voltage rating is sufficient for the $V_{D D}$ supply.
- Keep the input lines as short as possible.
- Use a solid ground plane to help reduce electromagnetic interference (EMI) noise pickup.
- Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if possible, and only make perpendicular crossings when necessary.


### 10.2 Layout Example



Figure 35. TMUX1109 Layout Example

## 11 Device and Documentation Support

### 11.1 Documentation Support

### 11.1.1 Related Documentation

Texas Instruments, True Differential, $4 \times 2$ MUX, Analog Front End, Simultaneous-Sampling ADC Circuit.
Texas Instruments, Improve Stability Issues with Low CON Multiplexers.
Texas Instruments, Simplifying Design with 1.8 V logic Muxes and Switches.
Texas Instruments, Eliminate Power Sequencing with Powered-off Protection Signal Switches.
Texas Instruments, System-Level Protection for High-Voltage Analog Multiplexers.
Texas Instruments, QFN/SON PCB Attachment.
Texas Instruments, Quad Flatpack No-Lead Logic Packages.

### 11.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to order now.

### 11.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on Alert me to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 11.4 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect Tl's views; see TI's Terms of Use.
TI E2ETM Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.
Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 11.5 Trademarks

E2E is a trademark of Texas Instruments.

### 11.6 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 11.7 Glossary

SLYZ022 - TI Glossary.
This glossary lists and explains terms, acronyms, and definitions.

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable Device | Status <br> (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <br> (2) | Lead finish/ Ball material (6) | MSL Peak Temp <br> (3) | Op Temp ( ${ }^{\circ} \mathrm{C}$ ) | Device Marking <br> (4/5) | Samples |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| TMUX1109PWR | ACTIVE | TSSOP | PW | 16 | 2000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | TM1109 | Samples |
| TMUX1109RSVR | ACTIVE | UQFN | RSV | 16 | 3000 | RoHS \& Green | NIPDAUAG | Level-1-260C-UNLIM | -40 to 125 | 1D1 | Samples |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device
${ }^{(2)}$ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as " Pb -Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the $<=1000 \mathrm{ppm}$ threshold requirement.
${ }^{(3)}$ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
${ }^{(4)}$ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
${ }^{(5)}$ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a " $\sim$ " will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
${ }^{(6)}$ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## TAPE AND REEL INFORMATION


*All dimensions are nominal

| Device | Package <br> Type | Package <br> Drawing | Pins | SPQ | Reel <br> Diameter <br> $(\mathbf{m m})$ | Reel <br> Width <br> $\mathbf{W 1}(\mathbf{m m})$ | A0 <br> $(\mathbf{m m})$ | B0 <br> $(\mathbf{m m})$ | K0 <br> $(\mathbf{m m})$ | P1 <br> $(\mathbf{m m})$ | $\mathbf{W}$ <br> $(\mathbf{m m})$ | Pin1 <br> Quadrant |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| TMUX1109PWR | TSSOP | PW | 16 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |
| TMUX1109RSVR | UQFN | RSV | 16 | 3000 | 178.0 | 13.5 | 2.1 | 2.9 | 0.75 | 4.0 | 12.0 | Q1 |


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| TMUX1109PWR | TSSOP | PW | 16 | 2000 | 853.0 | 449.0 | 35.0 |
| TMUX1109RSVR | UQFN | RSV | 16 | 3000 | 189.0 | 185.0 | 36.0 |



NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.


NOTES: (continued)
3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).


SOLDER PASTE EXAMPLE BASED ON 0.125 MM THICK STENCIL SCALE: 25X

NOTES: (continued)
4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.


NOTES: (continued)
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.


SOLDER PASTE EXAMPLE BASED ON 0.125 mm THICK STENCIL SCALE: 10X

NOTES: (continued)
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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[^0]:    (1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report

[^1]:    (1) When $V_{S}$ is $1 \mathrm{~V}, \mathrm{~V}_{\mathrm{D}}$ is 0.8 V , and vice versa.

